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		. DIC	OLOCUPE	Application Number	Unassigned - 10/007019	PT0	
			CLOSURE	Filing Date	Herewith		
STATEMENT BY APPLICANT				First Named Inventor	Gilman, Ralph A.	20	
				Group Art Unit	Unassigned- 2/36	00.	
(use as many sheets as necessary)				Examiner Name	Unassigned Col, N	30	
Sheet	1	of	1	Attorney Docket Number	A6425/T45100		
							

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Examiner tnitiats *	Cite No.'	U.S. Patent Doc Number Kind (if kn	Code ²	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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		Office ³	Number ⁴	Kind Code ⁵ (<i>if known</i>)	or Applicant of Cited Document	Cited Document MM-DD-YYYY	Passages or Relevant Figures Appear	T ⁶
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